

**Search Notes**

Application/Control No.

09/823,272

Examiner

Yubin Hung

Applicant(s)/Patent under  
Reexamination

SHIN ET AL.

Art Unit

2625

**SEARCHED**

Class	Subclass	Date	Examiner
382	162,165 168,173 181 190-192	8/30/2005	YH
	224-228		
	305,306		
358	403,404	8/30/2005	YH
702	1-6	8/30/2005	YH
	104.1		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text search (US PG_PUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	8/29/2005	YH
IEEE Xplore	8/29/2005	YH
ACM	8/29/2005	YH
SPIE	8/29/2005	YH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner